

## Lecture 9: Comparison of hypothesis tests

### 9.1 Synopsis of Hypothesis Testing

**Remark 9.1** Suppose our data come from  $f_X(x | \theta)$ ,  $\theta \in \Omega$  and we want to test the following hypothesis:

$$H_0 : \theta \in \omega_0 \quad \text{vs.} \quad H_1 : \theta \in \omega_1 \quad (\omega_0 \cap \omega_1 = \emptyset, \omega_0 \cup \omega_1 = \Omega).$$

Our *decision* to either reject  $H_0$  or fail to reject  $H_0$  is based upon the space of the sample  $\mathcal{D}$  where  $\mathcal{D} := \text{space}\{(X_1, \dots, X_n)\}$ . In particular, we reject  $H_0$  if  $(X_1, \dots, X_n) \in C$  where  $C \subseteq \mathcal{D}$  is called the *rejection/critical region*. We say  $C$  is of *size*  $\alpha$  if

$$\max_{\theta \in \omega_0} P_{\theta}[(X_1, \dots, X_n) \in C] = \alpha.$$

Next, the *significance level* is the maximum allowable probability of committing a *Type I error* and is defined *a priori*. A test has significance level  $\alpha$  if the size is less than or equal to  $\alpha$ . Then, among the critical regions that are size  $\alpha$ , we want to then minimize the probability of committing a *Type II Error* (i.e., accept  $H_0$  when  $H_1$  is true). Minimizing Type II Error is equivalent to maximizing *power*, where the *power function* of a critical region  $C$  is

$$\gamma_C(\theta) = P_{\theta}[(X_1, \dots, X_n) \in C], \quad \theta \in \omega_1.$$

**Example 9.1** Suppose  $X_1, \dots, X_n \stackrel{iid}{\sim} N(\mu, \sigma^2)$  where  $\sigma^2 > 0$  is known. We want to test the following hypothesis

$$H_0 : \mu = \mu_0 \quad \text{vs.} \quad H_1 : \mu < \mu_0$$

at a significance level  $\alpha = 0.05$ . Here are all of the possible ways to perform this test given an observation  $(x_1, \dots, x_n)$ .

- (i) Define my rejection region  $C$  to be

$$C := \{(X_1, \dots, X_n) \in \mathcal{D} \mid \bar{X} \leq c\}$$

where  $c$  is chosen to guarantee  $C$  is size  $\alpha$ . In particular, we find  $c$  as follows:

$$P_{\mu_0}(\bar{X} \leq c) = P_{\mu_0}\left(\frac{\bar{X} - \mu_0}{\sigma/\sqrt{n}} \leq \frac{c - \mu_0}{\sigma/\sqrt{n}}\right) = \alpha \implies \frac{c - \mu_0}{\sigma/\sqrt{n}} = z_{0.05} \implies c = \mu_0 + \frac{\sigma}{\sqrt{n}} \cdot z_{0.05}$$

where  $z_{0.05}$  is the  $\alpha = 0.05$  quantile of the standard normal distribution. Now, when we observe  $(x_1, \dots, x_n)$ , we reject  $H_0$  if  $\bar{x} \leq \mu_0 + \frac{\sigma}{\sqrt{n}} \cdot z_{0.05}$ .

- (ii) To make a decision on the hypotheses, we can compute an *observed significance level* (i.e., *p-value*) for our observations  $(x_1, \dots, x_n)$ . We still consider the same rejection rule as in part

(i), that is, “reject  $H_0$  in favor of  $H_1$  if  $\bar{X} \leq c$ .” However, instead of determining the value of  $c$  which determines the size of our test, we can ask “Is  $\bar{x}$  sufficiently small to reject  $H_0$  in favor of  $H_1$ ?” In particular, we compute the probability [under  $H_0$ ] that our test statistics is *as or more* extreme than our observation,

$$\text{p-value} = P_{\mu_0}(\bar{X} \leq \bar{x}).$$

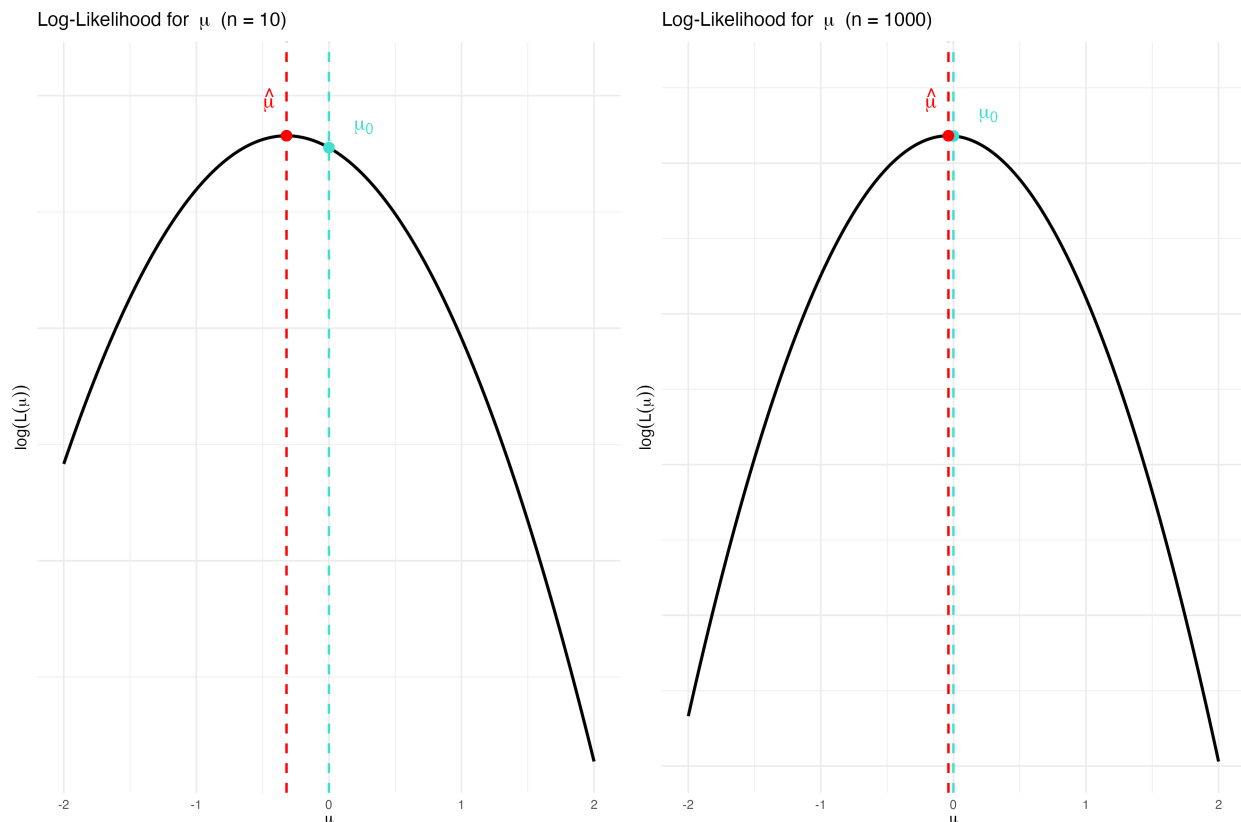
This *observed significance level* (i.e., p-value) is then compared to a *nominal*  $\alpha$  level and we reject if  $\text{p-value} \leq \alpha$ .

(iii) Instead of focusing on  $\bar{X}$  as the test statistic, instead we can compare the likelihood under  $H_0$  to the likelihood across the entire parameter space and conduct a *likelihood ratio test* (LRT). Specifically, we compute

$$\Lambda = \frac{L(\mu_0 | x_1, \dots, x_n)}{L(\hat{\mu}^{MLE} | x_1, \dots, x_n)}$$

and the decision rule becomes “reject  $H_0$  in favor of  $H_1$  if  $\Lambda \leq c$ ” where  $c \in [0, 1]$  is chosen such that  $\alpha = P_{\mu_0}(\Lambda \leq c)$ .

**Remark 9.2** Further insight into why  $\Lambda \leq 1$  for the LRT. Consider the following simulation study where  $X_1, \dots, X_n \stackrel{iid}{\sim} N(\mu, 1)$ . Assume the true value,  $\mu_0 = 0$ . We will compare the log-likelihood function  $l(\mu | x_1, \dots, x_n)$  for both  $n = 10$  and  $n = 1000$ .



## 9.2 Comparing Testing Methods

Let's consider the case of a *simple hypothesis* test for now, where both the null and alternative hypotheses are composed of a single probability distribution. This is the easiest way to understand the criteria for comparing testing methods. Consider a case where we test the following hypothesis using a random sample  $X_1, \dots, X_n \stackrel{iid}{\sim} f(x; \theta)$ , where  $\theta \in \Omega = \{\theta_0, \theta_1\}$

$$H_0 : \theta = \theta_0 \quad \text{vs} \quad H_1 : \theta = \theta_1$$

Let  $C$  denote the rejection region and  $\mathbf{X} = (X_1, \dots, X_n)$ . The error probabilities associated with the test method are defined in two ways.

- Type I Error Probability =  $P_{\theta_0}(\mathbf{X} \in C)$
- Type II Error Probability =  $P_{\theta_1}(\mathbf{X} \notin C) = 1 - P_{\theta_1}(\mathbf{X} \in C)$

**Definition 9.1** Let  $C$  denote a subset of the sample space  $\mathcal{D}$ . We say  $C$  is a **best critical region** of size  $\alpha$  for testing simple hypothesis  $H_0 : \theta = \theta_0$  versus  $H_1 : \theta = \theta_1$  if

- $P_{\theta_0}[(X_1, \dots, X_n) \in C] = \alpha$
- If  $P_{\theta_0}[(X_1, \dots, X_n) \in A] = \alpha$  ( $A \subseteq \mathcal{D}$ ), then  $P_{\theta_1}[(X_1, \dots, X_n) \in C] \geq P_{\theta_1}[(X_1, \dots, X_n) \in A]$ .

**Example 9.2** Suppose  $X \sim \text{Binomial}(n = 5, p = \theta)$  and  $f_X(x | \theta)$  denotes the pmf. We are interesting in testing  $H_0 : \theta = \frac{1}{2}$  versus  $H_1 : \theta = \frac{3}{4}$ . The following table provides the pmf values under each hypothesis as well as their ratio. We will use  $X$  as the test statistic (i.e., the rejection region is of the form  $X \in C$ ) at a significance level of  $\alpha = \frac{1}{32}$ . We want to find a best critical region of size  $\alpha = \frac{1}{32}$ .

$x$	0	1	2	3	4	5
$f(x; 1/2)$	1/32	5/32	10/32	10/32	5/32	1/32
$f(x; 3/4)$	1/1024	15/1024	90/1024	270/1024	405/1024	243/1024
$\frac{f(x; 1/2)}{f(x; 3/4)}$	32/1	32/3	32/9	32/27	32/81	32/243

*Solution.* First, let's find subsets of the sample space that are level  $\alpha = \frac{1}{32}$ . There exists two possible choices,  $A_1 = \{x | x = 0\}$  and  $A_2 = \{x | x = 5\}$  because

$$P(X \in A_1 | H_0) = P_{\{\theta=1/2\}}(X \in A_1) = \frac{1}{32}, \quad \text{and} \quad P(X \in A_2 | H_0) = P_{\{\theta=1/2\}}(X \in A_2) = \frac{1}{32}.$$

$A_1$  and  $A_2$  are all possible subsets of  $\mathcal{D}$  with level  $\alpha$ . In order to determine which  $A_1$  or  $A_2$  is the *best critical region*, we need to notice

$$\frac{243}{1024} = P_{\{\theta=3/4\}}(X \in A_2) > P_{\{\theta=3/4\}}(X \in A_1) = \frac{1}{1024},$$

which implies that the best critical region is  $A_2$ . ■

**Remark 9.3** Why did we include the ratio of densities in Example 9.2? We saw that the best critical region was found by including the point (or points) at which  $f(x | \theta = \frac{1}{2})$  is *small* in comparison to  $f(x | \theta = \frac{3}{4})$ . We see that for our best critical region  $A_2$ , the ratio  $\frac{f(x;1/2)}{f(x;3/4)}$  is minimized at  $x = 5$  (i.e.,  $A_2$ ). Thus, looking at this ratio provides a precise tool to find a best critical region  $C$  for any given size  $\alpha$ .

For example, now take  $\alpha = \frac{6}{32}$ . [Left as a homework problem to find the best critical region.]

**Remark 9.4** A hypothesis of the form  $H : \theta = \theta_0$  completely specifies the underlying distribution and is called a **simple** hypothesis. A hypothesis of the form, for example,  $H : \theta < \theta_0$  is a **composite** hypothesis because they are *composed* of many simple hypotheses (and hence do not completely specify the distribution).

**Theorem 9.1** (*Neyman-Pearson Theorem*): Let  $X_1, \dots, X_n \stackrel{iid}{\sim} f_X(x | \theta)$ . The likelihood of  $X_1, \dots, X_n$  is

$$L(\theta | \mathbf{x}) = \prod_{i=1}^n f_X(x_i | \theta), \quad \mathbf{x} = (x_1, \dots, x_n)^T.$$

Let  $\theta_0$  and  $\theta_1$  denote fixed values of  $\theta$  where  $\theta \in \Omega = \{\theta_0, \theta_1\}$ , and let  $k > 0$ . Let  $C$  be a subset of the sample space  $\mathcal{D}$ , where  $C$  has the following properties:

- (a)  $\frac{L(\theta_0 | \mathbf{x})}{L(\theta_1 | \mathbf{x})} \leq k$  for each  $\mathbf{x} \in C$ .
- (b)  $\frac{L(\theta_0 | \mathbf{x})}{L(\theta_1 | \mathbf{x})} \geq k$  for each  $\mathbf{x} \in C^c = \mathcal{D} \setminus C$ .
- (c)  $\alpha = P_{H_0}[\mathbf{X} \in C]$ .

Then  $C$  is a best critical region of size  $\alpha$  for testing  $H_0 : \theta = \theta_0$  versus  $H_1 : \theta = \theta_1$

**Example 9.3** Let  $X_1, \dots, X_n \stackrel{iid}{\sim} f_X(x | \theta)$  where

$$f_X(x | \theta) = \frac{1}{\sqrt{2\pi}} \exp\left(-\frac{(x - \theta)^2}{2}\right), \quad x \in (-\infty, \infty).$$

Determine the best critical region of size  $\alpha$  for testing  $H_0 : \theta = 0$  versus  $H_1 : \theta = 1$ .

*Solution.* Following the steps of Theorem 9.1, we first look at the ratio  $\frac{L(\theta_0 | \mathbf{x})}{L(\theta_1 | \mathbf{x})}$ .

$$\begin{aligned} \frac{L(\theta_0 | \mathbf{x})}{L(\theta_1 | \mathbf{x})} &= \frac{L(0 | \mathbf{x})}{L(1 | \mathbf{x})} \\ &= \frac{(1/\sqrt{2\pi})^n \exp(-\sum_{i=1}^n x_i^2/2)}{(1/\sqrt{2\pi})^n \exp(-\sum_{i=1}^n (x_i - 1)^2/2)} \\ &= \exp\left(\frac{n}{2} - \sum_{i=1}^n x_i\right) \end{aligned}$$

Let  $k > 0$ . Recall that the goal is to determine  $C$  (i.e., what  $(x_1, \dots, x_n)$  satisfy the three conditions in Theorem 9.1, and then these  $(x_1, \dots, x_n)$  make up our  $C$ ). Let's figure out a way to characterize the set of  $(x_1, \dots, x_n)$  that satisfy condition (a) of Theorem 9.1.

$$\begin{aligned} \exp\left(\frac{n}{2} - \sum_{i=1}^n x_i\right) &\leq k \\ \frac{n}{2} - \sum_{i=1}^n x_i &\leq \log(k) \\ \frac{n}{2} - \log(k) &\leq \sum_{i=1}^n x_i \end{aligned}$$

In this case, a best critical region is the set  $C = \{(x_1, \dots, x_n) \mid \sum_{i=1}^n x_i \geq c, \text{ where } c = \frac{n}{2} - \log(k)\}$ . Then the value of  $c$  can be chosen to achieve the desired size  $\alpha$  as in part (c) of Theorem 9.1. Notice that it would be equivalent to write the critical region as  $C = \{(x_1, \dots, x_n) \mid \bar{x} \geq c^*, \text{ where } c^* = \frac{1}{2} - \frac{\log(k)}{n}\}$ . Therefore, given observations  $(x_1^*, \dots, x_n^*)$ ,  $H_0$  would be rejected at significance level  $\alpha$  if  $\bar{x}^* \geq c^*$ .

■

**Remark 9.5** The simple hypotheses above only depend on *one* parameter, but the procedures above work for any finite number of parameters. The only requirement is that the hypotheses  $H_0$  and  $H_1$  be *simple*, in that they completely specify the distributions. Furthermore, the simple hypotheses  $H_0$  and  $H_1$  do **not** need to be hypotheses about the parameters of a distribution, **nor** do the random variables  $X_1, \dots, X_n$  need to be independent. That is, if  $H_0$  is the simple hypothesis that the joint pdf or pmf is  $g(x_1, \dots, x_n)$  and  $H_1$  is the simple hypothesis that the joint pdf or pmf is  $h(x_1, \dots, x_n)$ , then  $C$  is a best critical region of size  $\alpha$  if, for  $k > 0$ ,

- (a)  $\frac{g(x_1, \dots, x_n)}{h(x_1, \dots, x_n)} \leq k$ , for  $(x_1, \dots, x_n) \in C$ .
- (b)  $\frac{g(x_1, \dots, x_n)}{h(x_1, \dots, x_n)} \geq k$ , for  $(x_1, \dots, x_n) \in C^c = \mathcal{D} \setminus C$ .
- (c)  $\alpha = P_{H_0}[(X_1, \dots, X_n) \in C]$

**Definition 9.2** The critical region  $C$  is a **uniformly most powerful (UMP) critical region** of size  $\alpha$  for testing a *simple* hypothesis  $H_0$  against a *composite* hypothesis  $H_1$  if the set  $C$  is a best critical region of size  $\alpha$  for testing  $H_0$  against *each simple* hypothesis in  $H_1$ . A test defined by this critical region  $C$  is called a **UMP test**, with significance level  $\alpha$ , for testing the simple hypothesis  $H_0$  against the alternative composite hypothesis  $H_1$ .

**Example 9.4** Let  $X_1, \dots, X_n \stackrel{iid}{\sim} N(\theta, 1)$  with  $\theta$  unknown. Find the UMP test of the simple hypothesis  $H_0 : \theta = \theta_0$  versus the composite hypothesis  $H_1 : \theta > \theta_0$ .

*Solution.* In order to follow the steps of Theorem 9.1, let  $\theta_1 > \theta_0$  be parameter value in the

“alternative” parameter space. Then, for  $k > 0$ , we can determine a best rejection region  $C$  by

$$\begin{aligned} \frac{L(\theta_0 | \mathbf{x})}{L(\theta_1 | \mathbf{x})} &\leq k \\ \frac{(2\pi)^{-n/2} \exp(-\frac{1}{2} \sum_{i=1}^n (x_i - \theta_0)^2)}{(2\pi)^{-n/2} \exp(-\frac{1}{2} \sum_{i=1}^n (x_i - \theta_1)^2)} &\leq k \\ \exp\left\{ -(\theta_1 - \theta_0) \sum_{i=1}^n x_i + \frac{n}{2} [\theta_1^2 - \theta_0^2] \right\} &\leq k \\ (\theta_1 - \theta_0) \sum_{i=1}^n x_i &\geq \frac{n}{2} [\theta_1^2 - \theta_0^2] - \log k \\ \sum_{i=1}^n x_i &\geq \frac{n}{2} [\theta_1 + \theta_0] - \frac{\log k}{\theta_1 - \theta_0}. \end{aligned}$$

Therefore,

$$C := \left\{ (x_1, \dots, x_n) \mid \sum_{i=1}^n x_i \geq \frac{n}{2} [\theta_1 + \theta_0] - \frac{\log k}{\theta_1 - \theta_0} \right\}$$

and we can find a value for  $k$  such that  $C$  is of size  $\alpha$  and therefore is a best critical region of size  $\alpha$  for testing  $H_0 : \theta = \theta_0$  versus  $H_1 : \theta = \theta_1$  for  $\theta_1 > \theta_0$ . Since  $C$  is well defined for all  $\theta_1 > \theta_0$  (i.e., for all simple hypotheses composing the composite alternative hypothesis),  $C$  is a UMP critical region of size  $\alpha$  for testing  $H_0 : \theta = \theta_0$  versus  $H_1 : \theta > \theta_0$ . ■